

<b>Notice of References Cited</b>	Application/Control No. 10/710,673		Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Hiep Nguyen		Art Unit 2816	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,436,550	07-1995	Arakawa, Koji	323/222
*	B	US-5,905,369	05-1999	Ishii et al.	323/272
*	C	US-6,178,104	01-2001	Choi, Nak-Choon	363/89
*	D	US-6,185,082	02-2001	Yang, Ta-yung	361/90
*	E	US-6,222,746	04-2001	Kim, Hong-Ki	363/89
*	F	US-6,373,735	04-2002	Usui, Hiroshi	363/89
*	G	US-6,900,995	05-2005	Muegge et al.	363/21.05
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.